



SCS Directory

Accreditation number: SCS 0108

International standard: ISO/IEC 17025:2017
Swiss standard: SN EN ISO/IEC 17025:2018

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Initial accreditation: 17.09.2004
Current accreditation: 17.09.2024 to 16.09.2029
Scope of accreditation see: www.sas.admin.ch
(Accredited bodies)

Scope of accreditation as of 18.05.2026

Calibration Laboratory for Electric Field, Magnetic Field and SAR Sensors and Dielectric Measurement Instrumentation

Calibration and Measurement Capability (CMC)

| Measured Quantity / Instrument or Gauge | Measurement Range | Measurement Conditions | Best Measurement Uncertainty CMC at (22 ± 3) °C (1) | Remarks |
|---|---------------------|--|---|--|
| Electric field | | | | |
| Calibration of E-field probes | 0.8 V/m ... 800 V/m | 4 MHz ... 6 GHz | 5,1 % | e.g. ER3DV6x, EF3DVx, EU2DVx, EE3DVx, EL3DVx |
| Calibration of E-field probes | 10 V/m ... 2000 V/m | 750 MHz ... 6 GHz 6 GHz ... 110 GHz | 5,1 % 0,98 dB | e.g. EUmmWVx |
| Calibration of E-field probes | 2 V/m ... 420 V/m | 3 kHz ... 10 MHz | 1,06 dB | e.g.,MAGPY-8H3D+E3D |
| Magnetic field | | | | |
| Calibration of H-field probes | 2 mA/m ... 2 A/m | 4 MHz ... 3 GHz | 5,1 % | e.g. H2DVx, H3DVx, HL3DVx |
| Calibration of H-field probes | 10 A/m ... 2200 A/m | 3 kHz ... 10 MHz | 0,70 dB | e.g., MAGPY-8H3D+E3D |



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| Measured Quantity / Instrument or Gauge | Measurement Range | Measurement Conditions | Best Measurement Uncertainty CMC at (22 ± 3) °C (1) | Remarks |
|--|--|------------------------|---|--|
| Calibration of sensitivity for magnetic field probes in the audio range | 0,001 ... 0,1 V/(A/m) | 1 kHz 0,1 ... 1 A/m | 2,2 % | e.g. AM1DVx |
| Calibration of magnetic field simulator | -30 ... +40 dB A/m | 1 kHz | 4,1 % | e.g. TMFS (Telephone Magnetic Field Simulator) |
| Calibration of magnetic field simulators for validation and verification | 2.5 A/m ... 800 A/m | 3 kHz ... 10 MHz | 1.13 dB | e.g., V-Coil500/3, V-Coil350/85, V-Coil50/400, V-Coil50/6780 |
| Specific absorption rate (SAR) | | | | e.g. ET3Dvx, ES3Dvx, EX3Dvx, ET1Dvx, EU2Dvx |
| Calibration of dosimetric E-field probes | E* field (typical ²) 0,5 V/m ... 500 V/m | 4 MHz ... 450 MHz | 6,7 % (13,3 % for SAR) | Temperature transfer calibration *) As example, the indicated range corresponds to 0,2 mW/kg ... 200 W/kg for head tissue simulating liquid and f = 450 MHz |
| Calibration of dosimetric E-field probes | E* field (typical ²) 0,45 V/m ... 450 V/m | 750 MHz ... 3 GHz | 5,5 % (11 % for SAR) | e.g. ET3Dvx, ES3Dvx, EX3Dvx, ET1Dvx, EU2Dvx Waveguide analytical calibration *) As example, the indicated range corresponds to 0,2 mW/kg ... 200 W/kg for head tissue simulating liquid and f = 1800 MHz |
| Calibration of dosimetric E-field probes | 0,4 V/m ... 450 V/m | 3 GHz ... 6 GHz | 6,5 % (13,1 % for SAR) | Waveguide analytical calibration *) As example, the indicated range corresponds to 0,2 mW/kg ... 200 W/kg for head tissue simulating liquid and f = 5200 MHz |



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|--|---|---------------------------|---|--|
| Calibration of temperature SAR probes | 0,4 V/m ... 400 V/m | 6 GHz ... 10 GHz | 9,3 % (18,6 % for SAR) | Waveguide analytical calibration *) As example, the indicated range corresponds to 0,2 mW/kg ... 200 W/kg for head tissue simulating liquid and f = 7 GHz |
| | 0 °C ... + 60 °C | Tissue simulating Liquids | 0,15 K (5 % temperature gradient for SAR) | As example, the temperature gradient measured with T1Vx and T1V3LAB probes can be determined to 5 %, which is also a contribution to SAR accuracy. (Noise is dominating the lower SAR threshold to typically 0,2 W/kg) |
| Calibration of test system validation sources | SAR 1 g and 10 g per 1 W input power | 4 MHz ... 290 MHz | 18,4 % for SAR 1 g 18,0 % for SAR 10 g | e.g. CLA-6, CLA-13, CLA-30, CLA-64, CLA-128, CLA-150, CLA-220 according to IEC/IEEE 62209-1528 for 1 g and 10 g SAR |
| | | 300 MHz ... 700 MHz | 18,1 % for SAR 1 g 17,6 % for SAR 10 g | e.g. D835V2 ... D3000V2 according to IEC/IEEE 62209-1528, for 1 g and 10 g SAR |
| | SAR 1 g and 10 g per 1 W input power | 700 MHz ... 3 GHz | 17,0 % for SAR 1 g 16,5 % for SAR 10 g | |
| | | 3 GHz ... 6 GHz | 19,9 % for SAR 1 g 19,5 % for SAR 10 g | e.g. D3500V2 ... D5GHzV2 according to IEC/IEEE 62209-1528, for 1 g and 10 g SAR |
| Near-Field Calibration of dipoles in air | SAR 1 g and 10 g per 1 W input power | 6 GHz ... 10 GHz | 24,7 % for SAR 1 g 24,4 % for SAR 10 g | e.g. D6.5GHzV2 ... D9GHzV2 according to IEC/IEEE 62209-1528, for 1 g and 10 g SAR |
| | E field per 0,1 W input power 30 V/m ... 300 V/m | 700 MHz ... 6 GHz | 9,5 % for E field | e.g. CD835V3 ... CD5500V3 according to ANSI C 63.19, for E field and H field |
| | H field per 0,1 W input power 0,07 A/m ... 0,7 A/m | 385 MHz – 3 GHz | 8,3 % for H field | e.g. AdxxxV5 according to ANSI 14117 for H-field |



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|---|--|--|---|---|
| Calibration of Golden Validation Device | SAR 1 g and 10 g per GVD input power | 900 MHz | 15,0 % for SAR 1 g 15,1 % for SAR 10 g | e.g. GVD – SR 004001 AA |
| DC Voltage | | | | |
| Calibration of readout units for field and SAR probes | 2 mV 200 mV 1 mV ... 500 mV | | 1,5 % 1 % 1,16 % | e.g. DAE3Vx, DAE4Vx, DAEasyVx e.g. EASY6-DAE, DAE4ICEy |
| Calibration of SAR for planar array systems | SAR peak at 4 mm depth per 1 W input power | 650 MHz ... 3 GHz | 25,8 % for iSAR Flat 29,3 % for iSAR Head | e.g. iSAR Flat, iSAR Head |
| | SAR peak at 3 mm depth per 1 W input power | 650 MHz ... 3 GHz | 22,4 % for cSAR3D Flat 25,9 % for cSAR3D Left/Right Head | e.g., cSAR3D Flat, cSAR3D Left Head, cSAR3D Right Head |
| | SAR peak at 3 mm depth per 1 W input power | 3 GHz ... 6 GHz | 25,1 % for cSAR3D Flat 28,3 % for cSAR3D Left/Right Head | e.g., cSAR3D Flat, cSAR3D Left Head, cSAR3D Right Head |
| | SAR peak at 3 mm depth per 1 W input power | 6 GHz ... 10 GHz | 29,8 % for cSAR3D Flat | e.g. cSAR3D Flat, cSAR3D Quad |
| Calibration of antenna sources for transfer calibration of planar array systems | SAR peak per 1 W input power | 650 MHz ... 3 GHz | 17,7 % for SAR peak | e.g., SA AAE 083B, SA AAE 190 A, etc. |
| | SAR peak per 1 W input power | 3 GHz ... 6 GHz | 19,9 % for SAR peak | |
| Calibration of thermometers | 0 °C ... + 60 °C | | 0,1K | |
| Calibration of active electro-optical E&H-field probes optimized for close near-field evaluations in air | 15 mV/m ... 75 V/m 42 µA/m ... 0.5 A/m | 50 MHz ... 6000 MHz 50 MHz ... 6000 MHz | 3,3 dB 3,3 dB | for antenna factor (E-field) for antenna factor (H-field) |
| Calibration of active electro-optical RF over fiber systems | Gain: -55 ... 15dB | 10 MHz ... 10 GHz | 2,0 dB | For transfer function (gain) |



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|---|--|---|---|--|
| Calibration of stabilized RF power sources | - 5 dBm ... + 17 dBm | 600 MHz ... 6 GHz | 0,43 dB | e.g. Powersource1 |
| Calibration Procedure for sources in air above 6 GHz | 10 V/m ... 2000 V/m | 10 GHz... 110 GHz | 1,27 dB 1,47 dB 1,54 dB | e.g. verification source e.g. validation source e.g. general source |
| Calibration Procedure for sources in air above 6 GHz, for H and averaged S | 25 mA/m ... 2,5 A/m 2.5 W/m ² ...2,5 kW/m ² | 10 GHz... 110 GHz | 1,28 dB 1,63 dB 1,70 dB | e.g. verification source e.g. validation source e.g. general source |
| Absorbed Power Density (APD) | | | | |
| Calibration of dosimetric E-field probes for APD measurement | 20 V/m ... 550 V/m | 10 GHz ... 45 GHz | ±0.88dB (k=2) | e.g., EUAPDVx |
| Calibration of APD system verification sources | 1.0 W/m ² ... 800 W/m ² | 10 GHz ... 45 GHz | ±1.28dB, pAPD ±1.33dB, psAPD1cm ² ±1.38dB, psAPD4cm ² | e.g., APD verification sources |
| Measurement capability of the dielectric probe | Permittivity, Conductivity or Loss Tangent from | homogeneous isotropic material | | Open-ended coaxial probes, e.g. DAK-12, DAK-3.5, DAK-1.2 E |
| Permittivity | 1...15 | | | |
| | | 4 MHz ... 20 MHz 20 MHz ... 200 MHz 200 MHz ... 3 GHz 3 GHz ... 6 GHz 6 GHz ... 20 GHz 20 GHz ... 40 GHz 40 GHz ... 67 GHz 40 GHz ... 67 GHz | 24,3 % 11,2 % 2,0 % 2,0 % 2,1 % 3,2 % 3,2 % 4.5% | Loss tangent: < 0,1 Conductivity: > 10 S/m |
| | 10...40 | 4 MHz ... 10 MHz 10 MHz ... 50 MHz 50 MHz ... 200 MHz 200 MHz ... 3 GHz 3 GHz ... 6 GHz 6 GHz ... 20 GHz 20 GHz ... 40 GHz 40 GHz ... 67 GHz | 6,4 % 3,8 % 1,8 % 1,8 % 2,3 % 3,7 % 4,8 % 6,4 % | Conductivity: < 0,1 S/m Conductivity: < 0,1 S/m Conductivity: 0,1 – 10 S/m Conductivity: 0,1 – 10 S/m Conductivity: 1 – 10 S/m Conductivity: > 10 S/m Conductivity: > 10 S/m Conductivity: > 10 S/m |



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|---|-------------------|---|---|--|-------------------------------|------|----------------------|
| Conductivity | 35...100 | 4 MHz ... 10 MHz | 6,7 % | Conductivity: 0,1 – 1 S/m Conductivity: 0,1 – 1 S/m Conductivity: 1 – 10 S/m Conductivity: 1 – 10 S/m Conductivity: > 10 S/m | | | |
| | | 10 MHz ... 50 MHz | 2,9 % | | | | |
| | | 50 MHz ... 200 MHz | 2,2 % | | | | |
| | | 200 MHz ... 3 GHz | 1,7 % | | | | |
| | | 3 GHz ... 6 GHz | 1,9 % | | | | |
| | | 6 GHz ... 20 GHz | 2,4 % | | | | |
| Loss Tangent | 1 ... 10 S/m | 4 MHz ... 10 MHz | 3,1 % | Permittivity: 35 – 100 Permittivity: 35 – 100 Permittivity: 35 – 100 Permittivity: 35 – 100 Permittivity: 35 – 100 Permittivity: 10 – 40 Permittivity: 10 – 40 Permittivity: 1 – 15 | | | |
| | | 10 MHz ... 50 MHz | 2,9 % | | | | |
| | | 50 MHz ... 200 MHz | 2,5 % | | | | |
| | | 200 MHz ... 3 GHz | 3,2 % | | | | |
| | | 3 GHz ... 6 GHz | 3,0 % | | | | |
| | | 6 GHz ... 20 GHz | 3,0 % | | | | |
| Loss Tangent | >10 S/m | 20 GHz ... 40 GHz | 3,8 % | Permittivity: 10 – 40 Permittivity: 10 – 40 Permittivity: 1 – 15 | | | |
| | | 40 GHz ... 67 GHz | 4,7 % | | | | |
| | | Measurement capability of the dielectric probe for liquids and gels | 0 ... 0,1 | | 4 MHz ... 20 MHz | 0,46 | Permittivity: 1 – 15 |
| | | | | | 20 MHz ... 200 MHz | 0,28 | |
| | | | | | 200 MHz ... 3 GHz | 0,03 | |
| | | | | | 3 GHz ... 6 GHz | 0,03 | |
| 6 GHz ... 20 GHz | 0,03 | | | | | | |
| 20 GHz ... 40 GHz | 0,03 | | | | | | |
| Permittivity | 1...100 | 40 GHz ... 67 GHz | 0,03 | Open-ended coaxial probes, e.g. DAK-12, DAK-3.5, DAK-1.2 E | | | |
| | | 4 MHz ... 10 MHz | 6,4 % | | static conductivity < 0,1 S/m | | |
| | | 10 MHz ... 20 MHz | 3,8 % | | | | |
| | | 20 MHz ... 30 MHz | 2,3 % | | | | |
| | | 30 MHz ... 50 MHz | 1,9 % | | | | |
| | | 50 MHz ... 5 GHz | 2,2 % | | | | |
| Permittivity | 1...100 | 5 GHz ... 20 GHz | 3,7 % | static conductivity 0,1 – 10 S/m | | | |
| | | 4 MHz ... 10 MHz | 6,8 % | | | | |
| | | 10 MHz ... 20 MHz | 3,2 % | | | | |
| | | 20 MHz ... 30 MHz | 3,3 % | | | | |
| | | 30 MHz ... 50 MHz | 3,3 % | | | | |
| | | 50 MHz ... 5 GHz | 3,1 % | | | | |
| Permittivity | 1...100 | 5 GHz ... 20 GHz | 3,9 % | | | | |
| | | 20 GHz ... 40 GHz | 5,0 % | | | | |
| | | 40 GHz ... 67 GHz | 6,5 % | | | | |
| | | 20 GHz ... 40 GHz | 5,0 % | | | | |



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|--|---|--------------------------------|---|--------------|--|
| Conductivity | 0.01 ... 0,1 S/m | 300 MHz ... 500 MHz | 7,5 % | | Permittivity: 1 – 100 |
| | | 500 MHz ... 5 GHz | 4,4 % | | |
| | | 5 GHz ... 20 GHz | 5,4 % | | |
| Conductivity | 0,1 – 10 S/m | 4 MHz ... 10 MHz | 3,9 % | | Permittivity: 1 – 100 |
| | | 10 MHz ... 20 MHz | 3,9 % | | |
| | | 20 MHz ... 30 MHz | 3,8 % | | |
| | | 30 MHz ... 50 MHz | 3,4 % | | |
| | | 50 MHz ... 5 GHz | 4,8 % | | |
| | | 5 GHz ... 20 GHz | 4,8 % | | |
| | | 20 GHz ... 40 GHz | 4,8 % | | |
| | | 40 GHz ... 67 GHz | 4,9 % | | |
| Capability of the dielectric probe to measure thin layers of solids and liquids in small volume | Permittivity, Conductivity or Loss Tangent from | Homogeneous isotropic material | Permittivity | Loss tangent | Open-ended coaxial probes, e.g. DAK12-TL2, DAK3.5-TL2, DAK1.2E-TL2 |
| Permittivity | 1 < Permittivity < 10 | 4 MHz ... 20 MHz | --- | --- | 0.1 < thickness < 0.2 mm |
| Loss tangent | Loss tangent < 0,05 | 20 MHz ... 30 MHz | --- | --- | |
| | | 30 MHz ... 50 MHz | --- | --- | |
| | | 50 MHz ... 100 MHz | --- | --- | |
| | | 100 MHz ... 600 MHz | 32,6 % | 0,06 | |
| | | 600 MHz ... 3 GHz | 29,5 % | 0,03 | |
| | | 3 GHz ... 6 GHz | 12,6 % | 0,03 | |
| | | 6 GHz ... 20 GHz | 10,0 % | 0,03 | |
| | | 20 GHz ... 40 GHz | 9,1 % | 0,03 | |
| | | 40 GHz ... 67 GHz | 4,5 % | 0,03 | |
| | 1 < Permittivity < 10 Loss tangent < 0,05 | 4 MHz ... 20 MHz | 34,6 % | 0,45 | 0.2 < thickness < 1 mm |
| | | 20 MHz ... 30 MHz | 27,0 % | 0,27 | |
| | | 30 MHz ... 50 MHz | 25,6 % | 0,17 | |
| | | 50 MHz ... 100 MHz | 20,7 % | 0,10 | |
| | | 100 MHz ... 600 MHz | 9,1 % | 0,06 | |
| | | 600 MHz ... 3 GHz | 6,5 % | 0,03 | |
| | | 3 GHz ... 6 GHz | 3,7 % | 0,03 | |
| | | 6 GHz ... 20 GHz | 3,3 % | 0,03 | |
| | | 20 GHz ... 40 GHz | 3,9 % | 0,03 | |
| | | 40 GHz ... 67 GHz | 3,5 % | 0,03 | |
| | 1 < Permittivity < 10 Loss tangent < 0,05 | 4 MHz ... 20 MHz | 24,3 % | 0,45 | 1 < thickness < 10 mm |
| | | 20 MHz ... 30 MHz | 11,2 % | 0,27 | |
| | | 30 MHz ... 50 MHz | 7,1 % | 0,17 | |
| | | 50 MHz ... 100 MHz | 4,7 % | 0,10 | |
| | | 100 MHz ... 600 MHz | 2,7 % | 0,06 | |
| | | 600 MHz ... 3 GHz | 2,1 % | 0,03 | |
| | | 3 GHz ... 6 GHz | 2,0 % | 0,03 | |
| | | 6 GHz ... 20 GHz | 2,2 % | 0,03 | |
| | | 20 GHz ... 40 GHz | 3,9 % | 0,03 | |
| | | 40 GHz ... 67 GHz | 3,2 % | 0,03 | |



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|--|--|------------------------|---|------|--------------------------|
| 1 < Permittivity < 10 Loss tangent > 0,05 | 1 < Permittivity < 10 Loss tangent > 0,05 | 4 MHz ... 20 MHz | --- | --- | 0.1 < thickness < 0.2 mm |
| | | 20 MHz ... 30 MHz | --- | --- | |
| | | 30 MHz ... 50 MHz | --- | --- | |
| | | 50 MHz ... 100 MHz | --- | --- | |
| | | 100 MHz ... 600 MHz | 18,6 % | 0,06 | |
| | | 600 MHz ... 3 GHz | 24,6 % | 0,03 | |
| | | 3 GHz ... 6 GHz | 14,7 % | 0,03 | |
| | | 6 GHz ... 20 GHz | 8,3 % | 0,03 | |
| | | 20 GHz ... 40 GHz | 10,4 % | 0,03 | |
| | | 40 GHz ... 67 GHz | 4,7 % | 0,05 | |
| 1 < Permittivity < 10 Loss tangent > 0,05 | 1 < Permittivity < 10 Loss tangent > 0,05 | 4 MHz ... 20 MHz | --- | --- | 0.2 < thickness < 1 mm |
| | | 20 MHz ... 30 MHz | --- | --- | |
| | | 30 MHz ... 50 MHz | --- | --- | |
| | | 50 MHz ... 100 MHz | --- | --- | |
| | | 100 MHz ... 600 MHz | 29,8 % | 0,06 | |
| | | 600 MHz ... 3 GHz | 19,5 % | 0,03 | |
| | | 3 GHz ... 6 GHz | 8,0 % | 0,03 | |
| | | 6 GHz ... 20 GHz | 4,1 % | 0,03 | |
| | | 20 GHz ... 40 GHz | 4,3 % | 0,03 | |
| | | 40 GHz ... 67 GHz | 3,8 % | 0,03 | |
| 1 < Permittivity < 10 Loss tangent > 0,05 | 1 < Permittivity < 10 Loss tangent > 0,05 | 4 MHz ... 20 MHz | 24,3 % | 0,45 | 1 < thickness < 10 mm |
| | | 20 MHz ... 30 MHz | 11,2 % | 0,27 | |
| | | 30 MHz ... 50 MHz | 7,1 % | 0,17 | |
| | | 50 MHz ... 100 MHz | 4,7 % | 0,10 | |
| | | 100 MHz ... 600 MHz | 2,6 % | 0,06 | |
| | | 600 MHz ... 3 GHz | 2,0 % | 0,03 | |
| | | 3 GHz ... 6 GHz | 1,9 % | 0,03 | |
| | | 6 GHz ... 20 GHz | 2,0 % | 0,03 | |
| | | 20 GHz ... 40 GHz | 3,2 % | 0,03 | |
| | | 40 GHz ... 67 GHz | 3,1 % | 0,03 | |
| Permittivity > 10 Loss tangent < 0,05 | Permittivity > 10 Loss tangent < 0,05 | 4 MHz ... 20 MHz | 28,4 % | 0,45 | 0.1 < thickness < 0.2 mm |
| | | 20 MHz ... 30 MHz | 18,5 % | 0,27 | |
| | | 30 MHz ... 50 MHz | 12,6 % | 0,17 | |
| | | 50 MHz ... 100 MHz | 8,6 % | 0,10 | |
| | | 100 MHz ... 600 MHz | 5,7 % | 0,06 | |
| | | 600 MHz ... 3 GHz | 5,7 % | 0,03 | |
| | | 3 GHz ... 6 GHz | 5,7 % | 0,03 | |
| | | 6 GHz ... 20 GHz | 4,1 % | 0,03 | |
| | | 20 GHz ... 40 GHz | 4,6 % | 0,03 | |
| | | 40 GHz ... 67 GHz | 6,2 % | 0,03 | |
| Permittivity > 10 Loss tangent < 0,05 | Permittivity > 10 Loss tangent < 0,05 | 4 MHz ... 20 MHz | 24,7 % | 0,45 | 0.2 < thickness < 1 mm |
| | | 20 MHz ... 30 MHz | 12,1 % | 0,27 | |
| | | 30 MHz ... 50 MHz | 8,5 % | 0,17 | |
| | | 50 MHz ... 100 MHz | 6,6 % | 0,10 | |
| | | 100 MHz ... 600 MHz | 3,7 % | 0,06 | |
| | | 600 MHz ... 3 GHz | 4,0 % | 0,03 | |
| | | 3 GHz ... 6 GHz | 3,0 % | 0,03 | |
| | | 6 GHz ... 20 GHz | 3,5 % | 0,03 | |
| | | 20 GHz ... 40 GHz | 3,8 % | 0,03 | |
| | | 40 GHz ... 67 GHz | 3,9 % | 0,03 | |



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| | Permittivity >10 Loss tangent <0,05 | 4 MHz ... 20 MHz | 24,3 % | 0,45 | 1<thickness<10 mm |
| | | 20 MHz ... 30 MHz | 11,2 % | 0,27 | |
| | | 30 MHz ... 50 MHz | 7,1 % | 0,17 | |
| | | 50 MHz ... 100 MHz | 4,7 % | 0,10 | |
| | | 100 MHz ... 600 MHz | 2,6 % | 0,06 | |
| | | 600 MHz ... 3 GHz | 1,9 % | 0,03 | |
| | | 3 GHz ... 6 GHz | 1,9 % | 0,03 | |
| | | 6 GHz ... 20 GHz | 2,0 % | 0,03 | |
| | | 20 GHz ... 40 GHz | 4,5 % | 0,03 | |
| | 40 GHz ... 67 GHz | 3,6 % | 0,03 | | |
| | Permittivity >10 Loss tangent >0,05 | 4 MHz ... 20 MHz | 20,9 % | 0,35 | 0.1<thickness<0.2 mm |
| | | 20 MHz ... 30 MHz | 20,4 % | 0,35 | |
| | | 30 MHz ... 50 MHz | 15,3 % | 0,35 | |
| | | 50 MHz ... 100 MHz | 11,2 % | 0,25 | |
| | | 100 MHz ... 600 MHz | 7,9 % | 0,11 | |
| | | 600 MHz ... 3 GHz | 7,2 % | 0,02 | |
| | | 3 GHz ... 6 GHz | 5,3 % | 0,03 | |
| | | 6 GHz ... 20 GHz | 4,2 % | 0,05 | |
| | | 20 GHz ... 40 GHz | 6,4 % | 0,06 | |
| | 40 GHz ... 67 GHz | 8,9 % | 0,14 | | |
| | Permittivity >10 Loss tangent >0,05 | 4 MHz ... 20 MHz | 7,6 % | 0,35 | 0.2<thickness<1 mm |
| | | 20 MHz ... 30 MHz | 6,1 % | 0,35 | |
| | | 30 MHz ... 50 MHz | 6,1 % | 0,35 | |
| | | 50 MHz ... 100 MHz | 6,0 % | 0,25 | |
| | | 100 MHz ... 600 MHz | 4,8 % | 0,11 | |
| | | 600 MHz ... 3 GHz | 5,4 % | 0,02 | |
| | | 3 GHz ... 6 GHz | 3,5 % | 0,03 | |
| | | 6 GHz ... 20 GHz | 3,8 % | 0,05 | |
| | | 20 GHz ... 40 GHz | 5,2 % | 0,06 | |
| | 40 GHz ... 67 GHz | 6,0 % | 0,08 | | |
| | Permittivity >10 Loss tangent >0,05 | 4 MHz ... 20 MHz | 5,2 % | 0,35 | 1<thickness<10 mm |
| | | 20 MHz ... 30 MHz | 2,6 % | 0,35 | |
| | | 30 MHz ... 50 MHz | 2,6 % | 0,35 | |
| | | 50 MHz ... 100 MHz | 2,5 % | 0,25 | |
| | | 100 MHz ... 600 MHz | 2,5 % | 0,11 | |
| | | 600 MHz ... 3 GHz | 2,8 % | 0,02 | |
| 3 GHz ... 6 GHz | | 2,8 % | 0,03 | | |
| 6 GHz ... 20 GHz | | 3,6 % | 0,05 | | |
| 20 GHz ... 40 GHz | | 3,3 % | 0,06 | | |
| 40 GHz ... 67 GHz | 4,5 % | 0,08 | | | |



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|--|---|------------------------|---|-------|---|
| Permittivity Conductivity | Permittivity >10 Conductivity >0,5 S/m | 4 MHz ... 20 MHz | 6,4 % | 3,9 % | 1<thickness<10 mm |
| | | 20 MHz ... 30 MHz | 4,3 % | 3,4 % | |
| | | 30 MHz ... 50 MHz | 4,0 % | 3,4 % | |
| | | 50 MHz ... 100 MHz | 2,5 % | 3,4 % | |
| | | 100 MHz ... 600 MHz | 2,9 % | 3,4 % | |
| | | 600 MHz ... 3 GHz | 2,8 % | 5,8 % | |
| | | 3 GHz ... 6 GHz | 2,8 % | 4,0 % | |
| | | 6 GHz ... 20 GHz | 3,6 % | 4,0 % | |
| | | 20 GHz ... 40 GHz | 3,9 % | 4,1 % | |
| | | 40 GHz ... 67 GHz | 5,1 % | 5,0 % | |
| Measurement capability of low-loss thin materials | Permittivity <50 | 10 GHz ... 45 GHz (3) | 1% (all resonance frequencies) | | Sample thickness range is 0.05 - 3 mm |
| | Loss tangent <0.01 | | 1.0 × 10 ⁻⁴ (all resonance frequencies) | | The measurement method is based on the split cylinder resonator |

(2) Slightly depending on the frequency and probe type.

(3) Typical resonance frequencies of closed empty DAK-R: 10, 17, 26, 35 and 45 GHz

In case of contradictions in the language versions of the directories, the German version shall apply.

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